

**Notice of References Cited**

Application/Control No.

10/554,143

Applicant(s)/Patent Under  
Reexamination  
BOLCATO ET AL.

Examiner

JASON PROCTOR

Art Unit

2123

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,960,181	09-1999	Sanadidi et al.	703/21
*	B	US-6,424,959	07-2002	Bennett et al.	706/13
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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